

RoHS

COMPLIANT

AO4882-VB Datasheet

Dual N-Channel 40-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|----------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^a | Q _g (Typ.) | | | |
| 40 | 0.010 at V _{GS} = 10 V | 12 | 5.9 nC | | | |
| | 0.015 at V _{GS} = 4.5 V | 10 | 5.9110 | | | |

SO-8

Top View

S₁

G₁

S₂ 3

G₂ 4

2

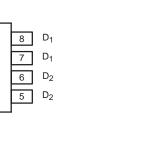
FEATURES

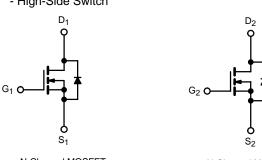
- Halogen-free
- TrenchFET[®] Power MOSFET
- Optimized for High-Side Synchronous Rectifier Operation
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

Notebook CPU Core

 High-Side Switch





N-Channel MOSFET

N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS $T_A = 25 \text{ °C}$, unless otherwise noted | | | | | |
|--|-----------------------------------|------------------|---------------------|------|------|
| Parameter | | Symbol | Limit | Unit | |
| Drain-Source Voltage | V _{DS} | 40 | V | | |
| Gate-Source Voltage | | V _{GS} | | | ± 20 |
| | T _C = 25 °C | - | 12 | | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 70 °C | | 10 | | |
| Continuous Diain Current (1j = 150°C) | T _A = 25 °C | Ι _D | 10 ^{b, c} | | |
| | T _A = 70 °C | | 8 ^{b, c} | А | |
| Pulsed Drain Current | | I _{DM} | 45 | A | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | le. | 3.2 | | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | 1.6 ^{b, c} | | |
| Single Pulse Avalanche Current | L = 0.1 mH | I _{AS} | 17 | | |
| Avalanche Energy | L = 0.1 mm | E _{AS} | 21 | mJ | |
| | T _C = 25 °C | - P _D | 4.1 | W | |
| Maximum Dowar Discipation | T _C = 70 °C | | 2.5 | | |
| Maximum Power Dissipation | T _A = 25 °C | | 2.1 ^{b, c} | vv | |
| | T _A = 70 °C | | 1.2 ^{b, c} | | |
| Operating Junction and Storage Temperature Ra | T _J , T _{stg} | - 55 to 150 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 10 s | R _{thJA} | 39 | 53 | °C/W | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 25 | 29 | C/VV | |

Notes:

a. Base on T_C = 25 °C.

b. Surface Mounted on 1" x 1" FR4 board.

c. t = 10 s. d. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$



| SPECIFICATIONS T _J = 25 °C, unless otherwise noted | | | | | | | | |
|---|---------------------------------------|---|-------|-------|-------|-------|--|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | | |
| Static | | | | | | - | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_{D} = 250 \mu A$ | 40 | | | V | | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 28 | | mV/°C | | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | $I_D = 230 \ \mu A$ | | - 6 | | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \ \mu A$ | 1.2 | | 2.5 | V | | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA | | |
| Zana Casta Malta na Duain Coursent | | $V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ | | | 1 | μA | | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = 40 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$ | | | 10 | | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$ | 20 | | | А | | |
| | | V _{GS} = 10 V, I _D = 10 A | 0.010 | | | | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 9 \text{ A}$ | | 0.015 | | Ω | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 10 A | | 52 | | S | | |
| Dynamic ^b | | | | | | | | |
| Input Capacitance | C _{iss} | | | 641 | 1 | pF | | |
| Output Capacitance | C _{oss} | V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz | | 175 | | | | |
| Reverse Transfer Capacitance | C _{rss} | 20 00 | | 73 | | | | |
| | | V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A | | 15 | 23 | nC | | |
| Total Gate Charge | Qg | | | 5.9 | 10.2 | | | |
| Gate-Source Charge | Q _{gs} | V _{DS} = 15 V, V _{GS} = 5 V, I _D = 10 A | | 2.5 | | | | |
| Gate-Drain Charge | Q _{gd} | | | 2.3 | | | | |
| Gate Resistance | R _g | f = 1 MHz | 0.36 | 1.8 | 3.6 | Ω | | |
| Turn-On Delay Time | t _{d(on)} | | | 16 | 24 | - | | |
| Rise Time | t _r | V_{DD} = 15 V, R ₁ = 1.4 Ω | | 12 | 18 | | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 9 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 16 | 24 | | | |
| Fall Time | t _f | | | 10 | 20 | | | |
| Turn-On Delay Time | t _{d(on)} | | | 8 | 16 | ns | | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 1.4 Ω | | 10 | 20 | - | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong 9 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | | 16 | 24 | | | |
| Fall Time | t _f | | | 8 | 15 | | | |
| Drain-Source Body Diode Characteristics | | | | | | | | |
| Continuous Source-Drain Diode Current | ۱ _S | T _C = 25 °C | | | 17 | | | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | 45 | A | | |
| Body Diode Voltage | V _{SD} | I _S = 9 A | | 0.8 | 1.2 | V | | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 15 | 30 | ns | | |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | 6 | 12 | nC | | |
| Reverse Recovery Fall Time | t _a | $I_F = 9 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 \text{ °C}$ | | 8 | | 1 | | |
| Reverse Recovery Rise Time | · · · · · · · · · · · · · · · · · · · | | | 7 | | ns | | |
| Notes: | 5 | | | 1 | 1 | 1 | | |

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



T_C = - 55 °C

 $T_C = 25 °C$

С

18

 $V_{GS} = 10 V$

50

75

V_{GS} = 4.5 V

100

24

30

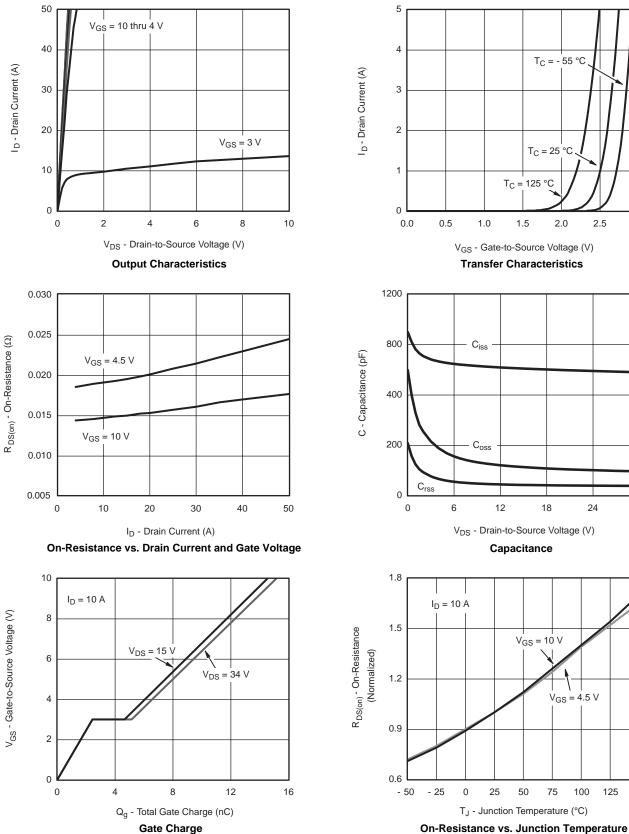
2.0

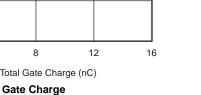
2.5

3.0

1.5

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted







125

150

3

2.2

2.0

1.8

1.6

1.4

1.2

1.0

- 50

- 25

0

25

50

T_J - Temperature (°C)

Threshold Voltage

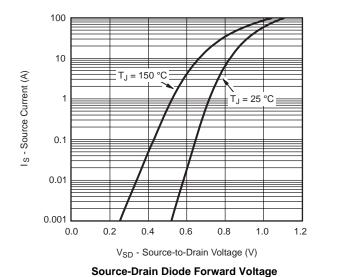
75

100

125

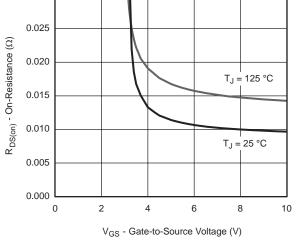
 $V_{GS(th)}$ (V)





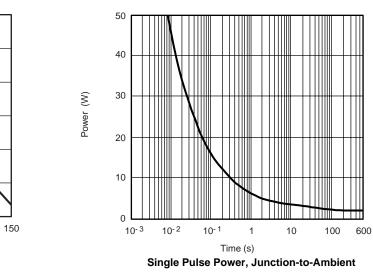
I_D = 250 μA

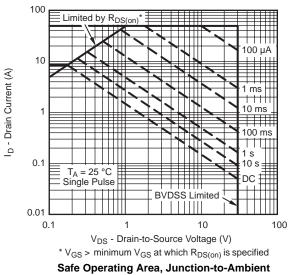
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



0.030

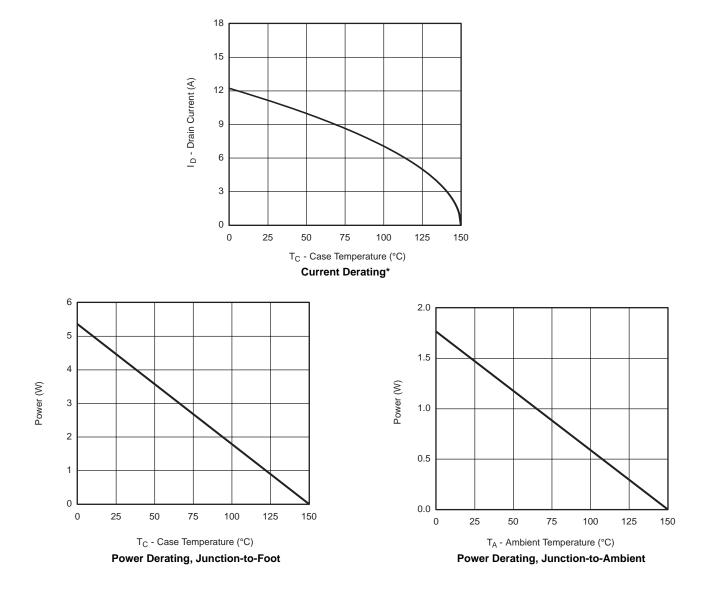
On-Resistance vs. Gate-to-Source Voltage





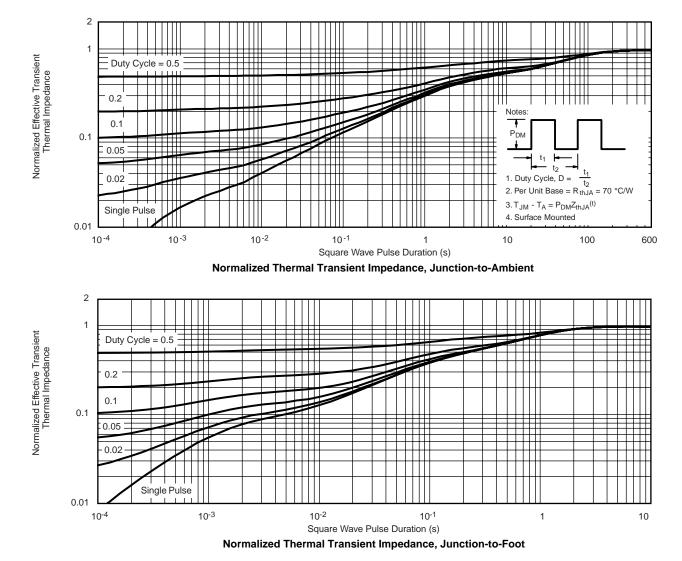


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



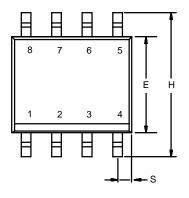


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

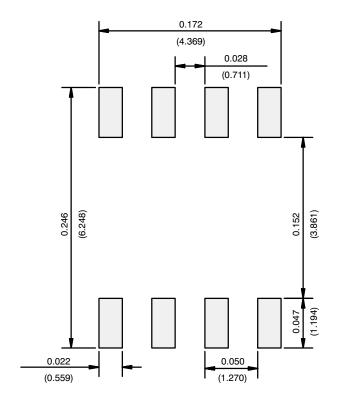




| | MILLIM | ETERS | INCHES | | |
|---|----------|-------|-----------|-------|--|
| DIM | Min | Мах | Min | Max | |
| A | 1.35 | 1.75 | 0.053 | 0.069 | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | |
| е | 1.27 BSC | | 0.050 BSC | | |
| н | 5.80 | 6.20 | 0.228 | 0.244 | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | |
| q | 0° | 8° | 0° | 8° | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | |
| ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498 | | | | | |



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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